

MULTI-INNO TECHNOLOGY CO., LTD.

www.multi-inno.com

OLED MODULE SPECIFICATION

Model : MI12864GAO-B

For Customer's Acceptance:

| Customer | | |
|----------|--|--|
| Approved | | |
| Comment | | |

| Revision | 1.1 |
|---------------|------------|
| Engineering | |
| Date | 2012-12-19 |
| Our Reference | |



REVISION RECORD

| REV NO. | REV DATE | CONTENTS | REMARKS |
|---------|------------|------------------|---------|
| 1.0 | 2012-03-07 | Preliminary | |
| 1.1 | 2012-12-19 | Update life time | |
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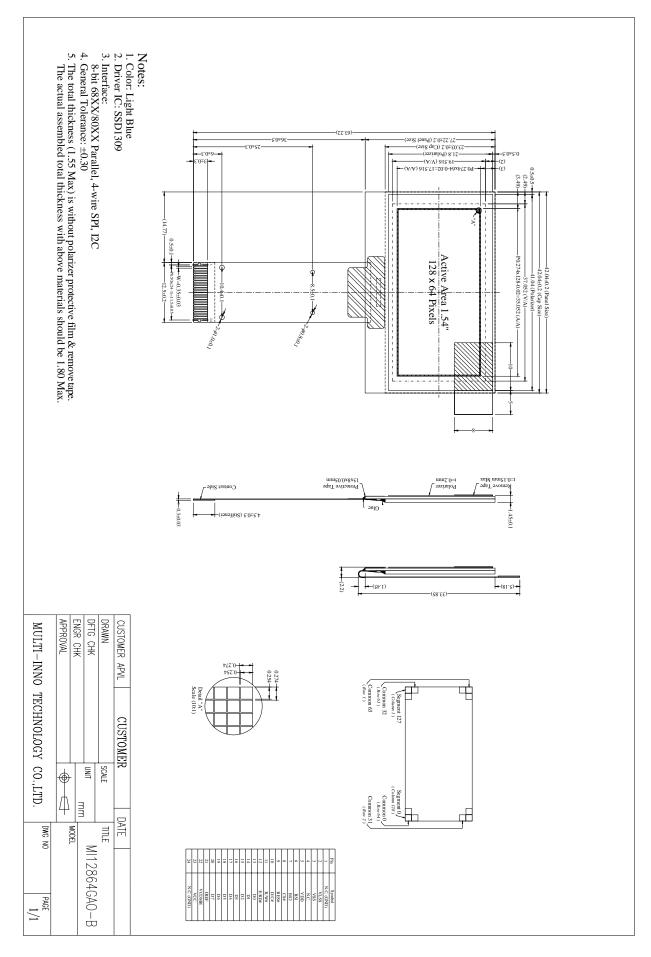


■ PHYSICAL DATA

| No. | Items | Specification | Unit |
|-----|-------------------|----------------------------------|-------|
| 1 | Display Mode | Passive Matrix OLED | - |
| 2 | Display Color | Monochrome (Light Blue) | - |
| 3 | Duty | 1/64 | - |
| 4 | Resolution | 128(H) x 64 (V) | Pixel |
| 5 | Active Area | 35.052 (W) x 17.516 (H) | mm |
| 6 | Outline Dimension | 42.04 (W) x 27.22 (H) x 1.45 (D) | mm |
| 7 | Pixel Pitch | 0.274 (W) x 0.274 (H) | mm |
| 8 | Pixel Size | 0.254 (W) x 0.254 (H) | mm |
| 9 | Driver IC | SSD1309 | - |
| 10 | Interface | 8-bit parallel,4-wire SPI,I2C | - |
| 11 | Weight | 3.28 | g |



EXTERNAL DIMENSIONS





ABSOLUTE MAXIMUM RATINGS

| Items | Symbol | Min | Тур. | Max | Unit | Notes |
|----------------------------------|-----------------|--------|------|------|------|-------|
| Supply voltage for logic | V _{DD} | -0.3 | - | 4 | V | 1,2 |
| Supply voltage for display | V _{CC} | 0 | - | 15.0 | V | 1,2 |
| Operating temperature | Тор | -40 | - | 70 | °C | 3 |
| Storage temperature | Tst | -40 | - | 85 | °C | 3 |
| Life time(120cd/m ²) | - | 20,000 | - | - | hour | 4 |
| Life time(80cd/m ²) | - | 20,000 | - | - | hour | 4 |
| Life time(60cd/m ²) | - | 25,000 | - | - | hour | 4 |
| Humidity | - | - | - | 90 | %RH | - |

Note 1: All the above voltages are on the basis of " $V_{SS} = 0V$ ".

Note 2: When this module is used beyond the above absolute maximum ratings, permanent breakage of the module may occur. Also, for normal operations, it is desirable to use this module under the conditions according to "electro-optical characteristics". If this module is used beyond these conditions, malfunctioning of the module can occur and the reliability of the module may deteriorate.

Note 3: The defined temperature ranges do not include the polarizer. The maximum withstood temperature temperature of the polarizer should be 80°C.

Note 4: V_{CC} = 12.5V, T_a = 25°C, 50% Checkerboard.

Software configuration follows Actual Application Example .

End of lifetime is specified as 50% of initial brightness reached. The average operating lifetime at room temperature is estimated by the accelerated operation at high temperature conditions.



ELECTRICAL CHARACTERISTICS

◆DC Characteristics

| Items | Symbol | Conditions | Min | Тур. | Max | Unit |
|--|-----------------------|-------------------------------|-----------------------|------|----------------------|------|
| Supply voltage for logic | V _{DD} | | 1.65 | 2.8 | 3.3 | V |
| Supply voltage for display | V _{CC} | Note 5 | 12 | 12.5 | 13 | V |
| High level input | V _{IH} | $I_{OUT} = 100 \mu A, 3.3 MH$ | $0.8 \ge V_{DD}$ | - | V _{DD} | V |
| Low level input | V _{IL} | $I_{OUT} = 100 \mu A, 3.3 MH$ | 0 | - | $0.2 \ge V_{DD}$ | V |
| High level output | V _{OH} | $I_{OUT} = 100 \mu A, 3.3 MH$ | 0.9 x V _{DD} | - | V _{DD} | V |
| Low level output | Vol | $I_{OUT} = 100 \mu A, 3.3 MH$ | 0 | - | 0.1x V _{DD} | V |
| Operating current for V _{DD} | I _{DD} | | - | 180 | 300 | μA |
| | | Note 6 | - | 11.8 | 14.8 | mA |
| Operating current for V _{CC} | I _{CC} | Note 7 | - | 19.1 | 23.9 | mA |
| | | Note 8 | - | 35.6 | 44.5 | mA |
| Sleep mode current for V _{DD} | I DD,SLEEP | | - | 1 | 5 | μA |
| Sleep mode current for V_{CC} | I _{CC,SLEEP} | | - | 2 | 10 | μA |

Note 5: Supply Voltage for Display (V_{CC}) are subject to the change of the panel characteristics and the customer's request.

Note 6: V_{DD} = 2.8V, V_{CC} = 12.5V, 30% Display Area Turn on.

Note 7: V_{DD} = 2.8V, V_{CC} = 12.5V, 50% Display Area Turn on.

Note 8: V_{DD} = 2.8V, V_{CC} = 12.5V, 100% Display Area Turn on.

* Software configuration follows Actual Application Example .



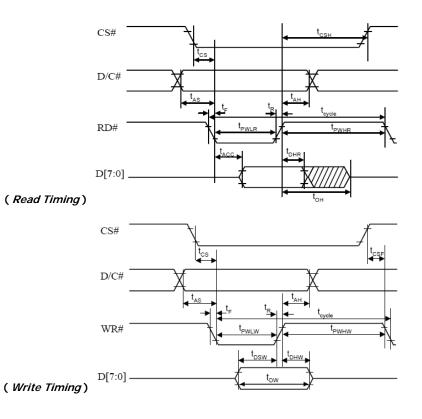
Ver 1.1

AC Characteristics

1. 80XX-Series MPU Parallel Interface Timing Characteristics:

| Symbol | Description | Min | Max | Unit |
|--------------------|--------------------------------------|-----|-----|------|
| t _{cycle} | Clock Cycle Time | 300 | - | ns |
| t _{AS} | Address Setup Time | 20 | - | ns |
| t _{AH} | Address Hold Time | 0 | - | ns |
| t_{DW} | Data Write Time | 70 | - | ns |
| t_{DSW} | Write Data Setup Time | 40 | - | ns |
| t_{DHW} | Write Data Hold Time | 15 | - | ns |
| t_{DHR} | Read Data Hold Time | 20 | - | ns |
| t _{он} | Output Disable Time | - | 70 | ns |
| t_{ACC} | Access Time | - | 140 | ns |
| t_{PWLR} | Read Low Time | 120 | - | ns |
| t _{PWLW} | Write Low Time | 60 | - | ns |
| t _{PWHR} | Read High Time | 60 | - | ns |
| t_{PWHW} | Write High Time | 60 | - | ns |
| t _{cs} | Chip Select Setup Time | 0 | - | ns |
| t _{CSH} | Chip Select Hold Time to Read Signal | 0 | - | ns |
| t_{CSF} | Chip Select Hold Time | 20 | - | ns |
| t _R | Rise Time | - | 40 | ns |
| t _F | Fall Time | - | 40 | ns |

* (V_{DD} - V_{SS} = 1.65V to 3.5V, T_a = 25°C)

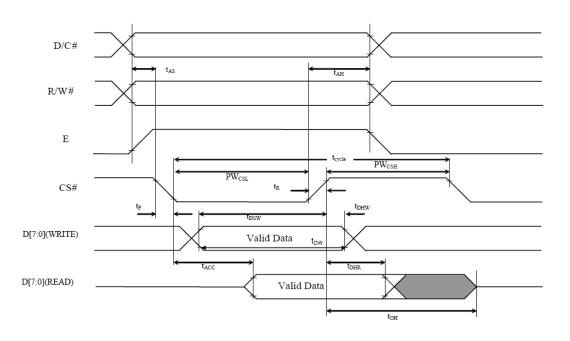




| Symbol | Description | Min | Мах | Unit |
|--------------------|--------------------------------------|-----|-----|------|
| t _{cycle} | Clock Cycle Time | 300 | - | ns |
| t _{AS} | Address Setup Time | 20 | - | ns |
| t _{AH} | Address Hold Time | 0 | - | ns |
| t _{DW} | Data Write Time | 80 | - | ns |
| t _{DSW} | Write Data Setup Time | 40 | - | ns |
| t _{DHW} | Write Data Hold Time | 20 | - | ns |
| t _{DHR} | Read Data Hold Time | 20 | - | ns |
| t _{он} | Output Disable Time | - | 70 | ns |
| t _{ACC} | Access Time | - | 140 | ns |
| | Chip Select Low Pulse Width (Read) | 120 | | |
| PW _{CSL} | Chip Select Low Pulse width (Write) | 60 | _ | ns |
| | Chip Select High Pulse Width (Read) | 60 | | 20 |
| PW _{CSH} | Chip Select High Pulse Width (Write) | 60 | 1 - | ns |
| t _R | Rise Time | - | 40 | ns |
| t _F | Fall Time | - | 40 | ns |

2. 68XX-Series MPU Parallel Interface Timing Characteristics:

* (V_{DD} - V_{SS} = 1.65V to 3.3V, T_a = 25°C)

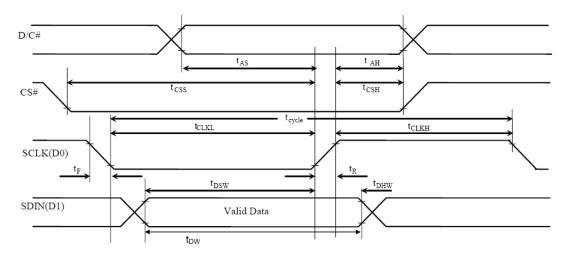


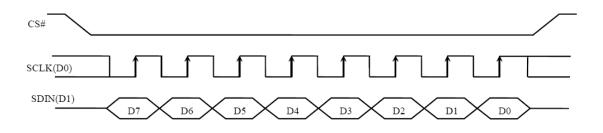


3. Serial Interface Timing Characteristics:

| Symbol | Description | Min | Max | Unit |
|--------------------|------------------------|-----|-----|------|
| t _{cycle} | Clock Cycle Time | 100 | - | ns |
| t _{AS} | Address Setup Time | 15 | - | ns |
| t _{AH} | Address Hold Time | 15 | - | ns |
| t _{css} | Chip Select Setup Time | 20 | - | ns |
| t _{CSH} | Chip Select Hold Time | 50 | - | ns |
| t _{DW} | Data Write Time | 55 | - | ns |
| t _{DSW} | Write Data Setup Time | 15 | - | ns |
| t _{DHW} | Write Data Hold Time | 15 | - | ns |
| t _{CLKL} | Clock Low Time | 50 | - | ns |
| t _{clĸн} | Clock High Time | 50 | - | ns |
| t _R | Rise Time | - | 40 | ns |
| t _F | Fall Time | - | 40 | ns |

* (V_{DD} - V = 1.65V to 3.5V, T = 25°C)



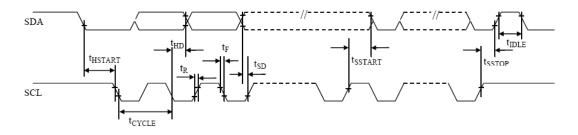




4. I²C Interface Timing Characteristics:

| Symbol | Description | Min | Max | Unit |
|---------------------|--|-----|-----|------|
| t _{cycle} | Clock Cycle Time | 2.5 | - | μs |
| t _{hstart} | Start Condition Hold Time | 0.6 | - | μs |
| | Data Hold Time (for "SDA _{OUT} " Pin) | 0 | | ns |
| LHD | t _{HD} Data Hold Time (for "SDA _{IN} " Pin) | | 300 | |
| t _{sD} | Data Setup Time | 100 | - | ns |
| t _{sstart} | Start Condition Setup Time (Only relevant for a repeated Start condition) | 0.6 | - | μs |
| t_{SSTOP} | Stop Condition Setup Time | 0.6 | - | μs |
| t _R | Rise Time for Data and Clock Pin | | 300 | ns |
| t _F | Fall Time for Data and Clock Pin | | 300 | ns |
| t_{IDLE} | Idle Time before a New Transmission can Start | 1.3 | - | μs |

* (V_{DD} - V_{SS} = 1.65V to 3.5V, T_a = 25°C)





■ TIMING OF POWER SUPPLY

1. Commands

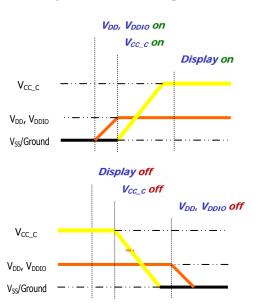
Refer to the Technical Manual for the SSD1309

2. Power down and Power up Sequence

To protect OEL panel and extend the panel life time, the driver IC power up/down routine should include a delay period between high voltage and low voltage power sources during turn on/off. It gives the OEL panel enough time to complete the action of charge and discharge before/after the operation.

2.1 Power up Sequence:

- 1. Power up V_{DD} & V_{DDIO}
- 2. Send Display off command
- 3. Initialization
- 4. Clear Screen
- 5. Power up $V_{CC C}$
- 6. Delay 100ms
- (When V_{CC_C} is stable) 7. Send Display on command
- 2.2 Power down Sequence:
 - 1. Send Display off command
 - 2. Power down $V_{CC C}$
 - Delay 100ms (When V_{CC_C} is reach 0 and panel is completely discharges)
 Power down V_{DD} & V_{DDIO}



Note 8:

- 1) Since an ESD protection circuit is connected between V_{DD} , V_{DDIO} and V_{CC_C} inside the driver IC, V_{CC_C} becomes lower than V_{DD} & V_{DDIO} whenever V_{DD} & V_{DDIO} is ON and \overline{V}_{CC_C} is OFF.
- 2) $V_{CC C}$ should be kept float (disable) when it is OFF.
- 3) Power Pins (V_{DD} , \hat{V}_{DDIO} , $V_{CC_{C}}$) can never be pulled to ground under any circumstance.
- 4) V_{DD} & V_{DDIO} should not be power down before V_{CC_C} power down.

3. Reset Circuit

When RES# input is low, the chip is initialized with the following status:

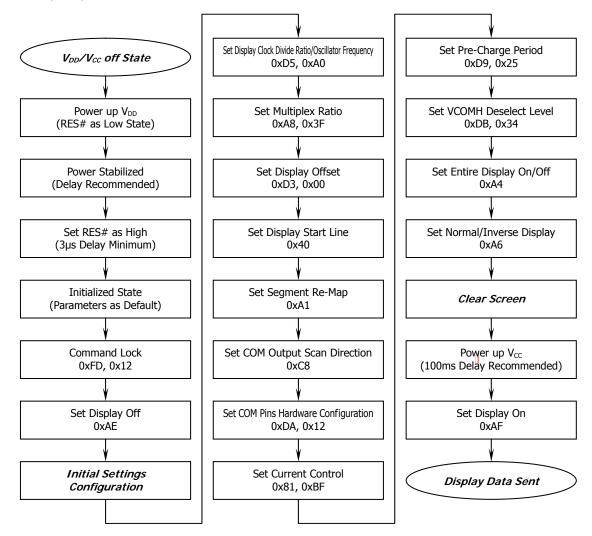
- 1. Display is OFF
- 2. 128×64 Display Mode
- 3. Normal segment and display data column and row address mapping (SEG0 mapped to column address 00h and COM0 mapped to row address 00h)
- 4. Shift register data clear in serial interface
- 5. Display start line is set at display RAM address 0
- 6. Column address counter is set at 0
- 7. Normal scan direction of the COM outputs
- 8. Contrast control register is set at 7Fh
- 9. Normal display mode (Equivalent to A4h command)



4. Actual Application Example

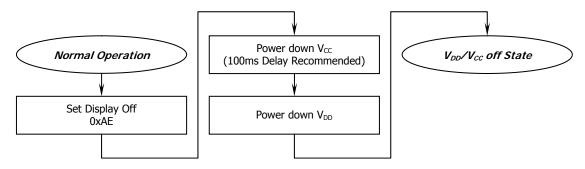
Command usage and explanation of an actual example

<Power up Sequence>



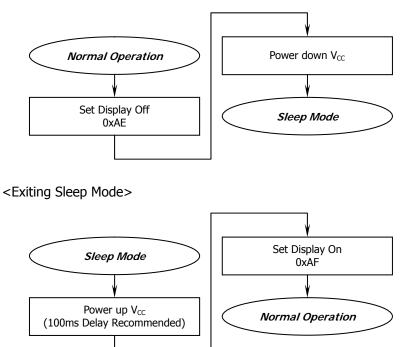
If the noise is accidentally occurred at the displaying window during the operation, please reset the display in order to recover the display function.

<Power down Sequence>





<Entering Sleep Mode>





■ ELECTRO-OPTICAL CHARACTERISTICS (Ta=25°C)

| Items | | Symbol | Min. | Тур. | Max. | Unit | Remark |
|-------------------|-----------|--------|---------|------|------|--------------------|--|
| Operating Lum | inance | L | 100 | 120 | - | cd /m ² | Blue |
| Power Consumption | | Р | - | - | - | mW | 30% pixels ON L=110cd/m ² |
| Frame Freque | ency | Fr | - | - | - | Hz | |
| Color Coordinate | Blue | CIE x | 0.12 | 0.16 | 0.20 | CIE1931 | Darkroom |
| | Diuc | CIE y | 0.22 | 0.26 | 0.30 | CIE1951 | Darktoolli |
| Desnonse Time | Rise | Tr | - | - | - | ms | - |
| Response Time | Decay | Td | - | - | - | ms | - |
| Contrast Ratio* | | Cr | 10000:1 | - | - | | Darkroom |
| Viewing Angle U | niformity | θ | - | Free | - | Degree | - |

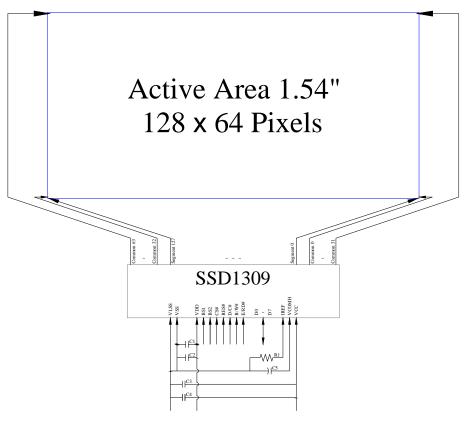
Note : Brightness (L br) is subject to the change of the panel characteristics and the customer's request. * Optical measurement taken at $V_{DD} = 2.8V$, $V_{CC} = 12.5V$.

Software configuration follows Actual Application Example .



■ INTERFACE PIN CONNECTIONS

1. Block Diagram



MCU Interface Selection: BS1 and BS2 Pins connected to MCU interface: CS#, RES#, D/C#, R/W#, E/RD#, and D0~D7

- C1, C3: 0.1µF
- C2: 4.7µF
- C4: 10µF
- C5: 4.7µF / 25V Tantalum Capacitor
- R1: 910k Ω , R1 = (Voltage at IREF BGGND) / IREF



2. Pin Definition

| Pin Number | Symbol | 1/0 | | Funct | ion | | | |
|--------------|------------|-----|--|---|---|--|--|--|
| Power Supply | y | _ | | | | | | |
| 5 | VDD | Р | Power Supply for Logic Circ | | | | | |
| 3 | VSS | Р | This is a voltage supply pin. It must be connected to external source. Ground of Logic Circuit This is a ground pin. It also acts as a reference for the logic pins. It must be connected to external ground. | | | | | |
| 23 | VCC | Р | Power Supply for OEL Panel This is the most positive voltage supply pin of the chip. It must be supplied externally. | | | | | |
| 2 | VLSS | Р | Ground of Analog Circuit This is an analog ground pin. | It should b | e connected | d to V _{ss} externally. | | |
| Driver | | _ | | | | | | |
| 21 | IREF | I | Current Reference for Brigh This pin is segment current between this pin and V _{SS} . See | reference | pin. A res | | | |
| 22 | VCOMH | о | Voltage Output High Level to This pin is the input pin for capacitor should be connected | the voltage | output high | | | |
| Interface | | | | | • | | | |
| 6 7 | BS1 BS2 | I | Communicating Protocol Se These pins are MCU interface I ² C 4-wire SPI 8-bit 68XX Parallel 8-bit 80XX Parallel | elect selection inj BS1 1 0 0 1 | out. See th BS2 0 0 1 1 | e following table: | | |
| 9 | RES# | I | Power Reset for Controller This pin is reset signal input executed. Keep this pin pull | . When the | e pin is low, | | | |
| 8 | CS# | I | Chip Select This pin is the chip select inpu when CS# is pulled low. | | | | | |
| 10 | D/C# | I | Data/Command Control This pin is Data/Command co D7~D0 will be interpreted as at D7~D0 will be transferred When the pin is pulled high ar will be interpreted as data. transferred to the command r address selection. For detail relationship to M Characteristics Diagrams. | display data to the comm nd serial inte When it is register. In CU interface | . When the and register rface mode is pulled low I ² C mode, t | e pin is pulled low, the input : is selected, the data at SDIN , the data at SDIN will be his pin acts as SA0 for slave | | |
| 12 | E/RD# | I | Read/Write Enable or Read This pin is MCU interface input. When interfacing to a 68XX-series microprocessor, this pin will be used as the Enable (E) signal. Read/write operation is initiated when this pin is pulled high and the CS# is pulled low. When connecting to an 80XX-microprocessor, this pin receives the Read (RD#) signal. Data read operation is initiated when this pin is pulled low and CS# is pulled low. When serial or I ² C mode is selected, this pin must be connected to V _{SS} . | | | | | |
| 11 | R/W# | I | Read/Write Select or Write This pin is MCU interface microprocessor, this pin will b this pin to "High" for read mo When 80XX interface mode i Data write operation is initiate low. When serial or I ² C mode is se | e input. le used as R de and pull s selected, ed when this | When inte ead/Write (F it to "Low" f this pin will pin is pulle | erfacing to a 68XX-series R/W#) selection input. Pull or write mode. be the Write (WR#) input. d low and the CS# is pulled | | |



| Pin Number | Symbol | 1/0 | Function | | | | |
|----------------------|------------|-----|--|--|--|--|--|
| Interface(Continued) | | | | | | | |
| 13~20 | D0~D7 | I/O | Host Data Input/Output Bus These pins are 8-bit bi-directional data bus to be connected to the microprocessor's data bus. When serial mode is selected, D1 will be the serial data input SDIN and D0 will be the serial clock input SCLK. When I ² C mode is selected, D2, D1 should be tired together and serve as SDA _{OUT} , SDA _{IN} in application and D0 is the serial clock input, SCL. Unused pins must be connected to V _{ss} except for D2 in serial mode. | | | | |
| Reserve | | | | | | | |
| 4 | N.C. | - | Reserved Pin The N.C. pin between function pins are reserved for compatible and flexible design. | | | | |
| 1, 24 | N.C. (GND) | - | Reserved Pin (Supporting Pin) The supporting pins can reduce the influences from stresses on the function pins. These pins must be connected to external ground as the ESD protection circuit. | | | | |



RELIABILITY TESTS

| | Item | Condition | Criterion | |
|--|--|---|--|--|
| High Te | emperature Storage (HTS) | 85±2°C, 240 hours | After testing, the function test is ok. After testing, no addition to the defect. | |
| High Ter | nperature Operating (HTO) | $70\pm2^\circ$ C, 240 hours | 3. After testing, the change of luminance should be within +/- 50% of initial value. | |
| Low Temperature Storage (LTS) | | -40 $\pm 2^{\circ}$ C, 240 hours | 4. After testing, the change for the mono and area color must be within (+/-0.02, +/- | |
| Low Temperature Operating (LTO) | | -40 \pm 2°C, 240 hours | 0.02) and for the full color it must be within (+/-0.04, +/-0.04) of initial value based on | |
| High Temperature / High Humidity Storage (HTHHS) | | 60±3℃, 90%±3%RH, 120 hours | 5. After testing, the change of total current consumption should be | |
| Thermal Shock (Non-operation) (TS) | | -40±2°C ~ 25°C ~ 85±2°C (30min) (5min) (30min) 24cycles | within +/- 50% of initial value. | |
| Vibration (Packing) | 10~55~10Hz,amplitu de 1.5mm, 1 hour for each direction x, y, z | One box for each test. No addition to the cosmetic and the electrical defects. | | |
| Drop (Packing) | Height : 1 m, each time for 6 sides, 3 edges, 1 angle | | | |

Note: 1) For each reliability test, the sample quantity is 3, and only for one test item.

2) The HTHHS test is requested the Pure Water(Resistance>10M Ω).

■OUTGOING QUALITY CONTROL SPECIFICATION

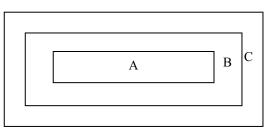
◆ Standard

According to GB/T2828.1-2003/ISO 2859-1: 1999 and ANSI/ASQC Z1.4-1993, General Inspection Level II.

Definition

1 Major defect : The defect that greatly affect the usability of product.

- 2 Minor defect : The other defects, such as cosmetic defects, etc.
- 3 Definition of inspection zone:



Zone A: Active Area

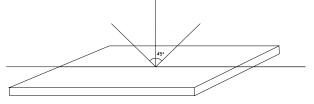
Zone B: Viewing Area except Zone A

Zone C: Outside Viewing Area

Note: As a general rule, visual defects in Zone C are permissible, when it is no trouble of quality and assembly to customer's product.

♦Inspection Methods

1 The general inspection : under 20W x 2 or 40W fluorescent light, about 30cm viewing distance, within 45° viewing angle, under 25±5℃.



2 The luminance and color coordinate inspection : By PR705 or BM-7 or the equal equipments, in the dark room, under 25±5℃.

Inspection Criteria

1 Major defect : AQL= 0.65

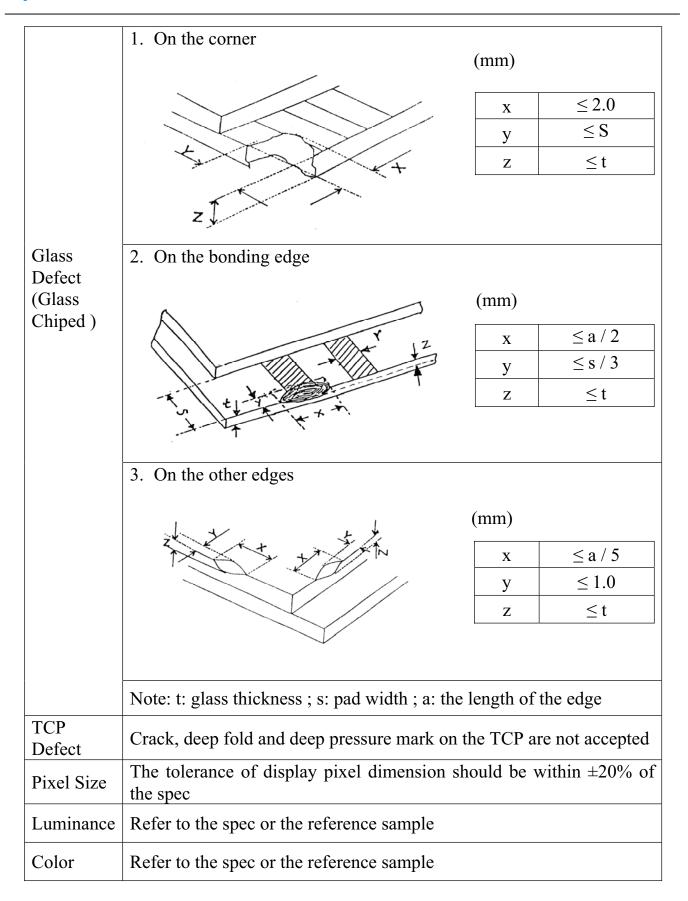
| Item | Criterion | | | | |
|-------------------|--|--|--|--|--|
| | 1. No display or abnormal display is not accepted | | | | |
| Function Defect | 2. Open or short is not accepted. | | | | |
| | 3. Power consumption exceeding the spec is not accepted. | | | | |
| Outline Dimension | Outline dimension exceeding the spec is not accepted. | | | | |
| Glass Crack | Glass crack tends to enlarge is not accepted. | | | | |
| | | | | | |

2 Minor Defect : AQL= 1.5



| Item | Criterion | | | | | | | |
|---|--|---|-----------------|---------|--|--|--|--|
| Spot Defect (dimming and lighting spot) | Size | (mm) | Accepted Qty | | | | | |
| | | | Area A + Area B | Area C | | | | |
| | | Φ≦0.10 | Ignored | | | | | |
| | | 0.10<Φ≦0.15 | 3 | Ignored | | | | |
| | X | 0.15<Φ≦0.20 | 1 | | | | | |
| | | 0.20<Φ | 0 | | | | | |
| | Note : $\Phi = (x + y) / 2$ | | | | | | | |
| Line Defect (dimming and lighting | L (Length):mm | W (Width):mm | Area A + Area B | Area C | | | | |
| | / | W≦0.03 | Ignored | | | | | |
| | L≦3.0 | $0.03 \! < \! W \! \le \! 0.05$ | 2 | 2 | | | | |
| | L≦2.0 | $0.05 \le W \le 0.08$ | 1 | Ignored | | | | |
| line) | / | 0.08 <w< td=""><td>As spot defect</td></w<> | As spot defect | | | | | |
| Remarks: The total of spot defect and line defect shall not exceed 4 pcs. | | | | | | | | |
| Polarizer Stain | Stain which can be wiped off lightly with a soft cloth or similar cleaning is accepted, otherwise, according to the Spot Defect and the Line Defect. | | | | | | | |
| | If scratch can be seen during operation, according to the criterions of the Spot Defect and the Line Defect. | | | | | | | |
| Polarizer Scratch | 2. If scratch can be seen only under non-operation or some special angle, the criterion is as below : | | | | | | | |
| | L (Length): mm | W (Width):mm | Area A + Area B | Area C | | | | |
| | / | W≦0.03 | Ignore | | | | | |
| | $5.0 < L \le 10.0$ | $0.03 \le W \le 0.05$ | 2 | | | | | |
| | L≦5.0 | $0.05 \le W \le 0.08$ | 1 | Ignore | | | | |
| | / | 0.08 <w< td=""><td>0</td><td></td></w<> | 0 | | | | | |
| | Si | Area A + Area B | Area C | | | | | |
| D.1. | | $\Phi \leq 0.20$ | Ignored | | | | | |
| Polarizer Air Bubble | Y | $0.20 < \Phi \le 0.50$ | 2 | Ignored | | | | |
| | X | $0.50 < \Phi \le 0.80$ | 1 | | | | | |
| | | $0.80{<}\Phi$ | 0 | | | | | |







■ CAUTIONS IN USING OLED MODULE

Precautions For Handling OLED Module:

- 1. OLED module consists of glass and polarizer. Pay attention to the following items when handling:
 - i. Avoid drop from high, avoid excessive impact and pressure.
 - ii. Do not touch, push or rub the exposed polarizers with anything harder than an HB pencil lead.
 - iii. If the surface becomes dirty, breathe on the surface and gently wipe it off with a soft dry cloth. If it is terrible dirty, moisten the soft cloth with Isopropyl alcohol or Ethyl alcohol. Other solvents may damage the polarizer. Especially water, Ketone and Aromatic solvents.
 - iv. Wipe off saliva or water drops immediately, contact the polarizer with water over a long period of time may cause deformation.
 - v. Please keep the temperature within specified range for use and storage. Polarization degradation, bubble generation or polarizer peeling-off may occur with high temperature and high humidity.
 - vi. Condensation on the surface and the terminals due to cold or anything will damage, stain or dirty the polarizer, so make it clean as the way of iii.
- 2. Do not attempt to disassemble or process the OLED Module.
- 3. Make sure the TCP or the FPC of the Module is free of twisting, warping and distortion, do not pull or bend them forcefully, especially the soldering pins. On the other side, the SLIT part of the TCP is made to bend in the necessary case.
- 4. When assembling the module into other equipment, give the glass enough space to avoid excessive pressure on the glass, especially the glass cover which is much more fragile.
- 5. Be sure to keep the air pressure under 120 kPa, otherwise the glass cover is to be cracked.
- 6. Be careful to prevent damage by static electricity:
 - i. Be sure to ground the body when handling the OLED Modules.
 - ii. All machines and tools required for assembling, such as soldering irons, must be properly grounded.
 - iii. Do not assemble and do no other work under dry conditions to reduce the amount of static electricity generated. A relative humidity of 50%-60% is recommended.
 - iv. Peel off the protective film slowly to avoid the amount of static electricity generated.
 - v. Avoid to touch the circuit, the soldering pins and the IC on the Module by the body.
 - vi. Be sure to use anti-static package.
- 7. Contamination on terminals can cause an electrochemical reaction and corrade the terminal circuit, so make it clean anytime.
- 8. All terminals should be open, do not attach any conductor or semiconductor on the terminals.
- 9. When the logic circuit power is off, do not apply the input signals.
- 10. Power on sequence: $V_{DD} \rightarrow V_{PP}$, and power off sequence: $V_{PP} \rightarrow V_{DD}$.
- 11. Be sure to keep temperature, humidity and voltage within the ranges of the spec, otherwise shorten Module' s life time, even make it damaged.
- 12. Be sure to drive the OLED Module following the Specification and Datasheet of IC controller, otherwise something wrong may be seen.



13. When displaying images, keep them rolling, and avoid one fixed image displaying more than 30 seconds, otherwise the residue image is to be seen. This is the speciality of OLED.

Precautions For Soldering OLED Module:

- 1. Soldering temperature : $260^{\circ}C \pm 10^{\circ}C$.
- 2. Soldering time : 3-4 sec.
- 3. Repeating time : no more than 3 times.
- 4. If soldering flux is used, be sure to remove any remaining flux after finishing soldering operation. (This does not apply in the case of a non-halogen type of flux.) It is recommended to protect the surface with a cover during soldering to prevent any damage due to flux spatters.

Precautions For Storing OLED Module:

- 1. Be sure to store the OLED Module in the vacuum bag with dessicant.
- 2. If the Module can not be used up in 1 month after the bag being opened, make sure to seal the Module in the vacuum bag with dessicant again.
- 3. Store the Module in a dark place, do not expose to sunlight or fluorescent light.
- 4. The polarizer surface should not touch any other objects. It is recommended to store the Module in the shipping container.
- 5. It is recommended to keep the temperature between $0^\circ C$ and $30^\circ C$, the relative humidity not over 60%.

♦ Limited Warranty

Unless relevant quality agreements signed with customer and law enforcement, for a period of 12 months from date of production, all products (except automotive products) Multi-Inno will replace or repair any of its OLED modules which are found to be functional defect when inspected in accordance with Multi-Inno OLED acceptance standards (copies available upon request). Cosmetic/visual defects must be returned to Multi-Inno within 90 days of shipment. Confirmation of such date should be based on freight documents. The warranty liability of Multi-Inno is limited to repair and/or replacement on the terms above. Multi-Inno will not be responsible for any subsequent or consequential events.

♦Return OLED Module Under Warranty:

- 1. No warranty in the case that the precautions are disregarded.
- 2. Module repairs will be invoiced to the customer upon mutual agreement. Modules must be returned with sufficient description of the failures or defects.